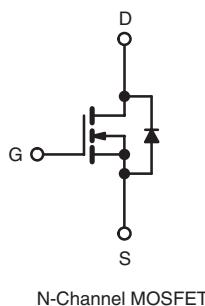
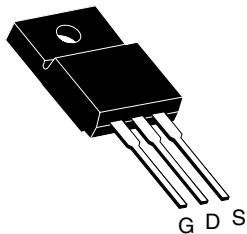


# Power MOSFET

PRODUCT SUMMARY		
$V_{DS}$ (V)	500	
$R_{DS(on)}$ ( $\Omega$ )	$V_{GS} = 10$ V	0.67
$Q_g$ (Max.) (nC)	45	
$Q_{gs}$ (nC)	13	
$Q_{gd}$ (nC)	23	
Configuration	Single	

**TO-220 FULLPAK**


## FEATURES

- Super Fast Body Diode Eliminates the Need for External Diodes in ZVS Applications
- Lower Gate Charge Results in Simpler Drive Requirements
- Enhanced dV/dt Capabilities Offer Improved Ruggedness
- Higher Gate Voltage Threshold Offers Improved Noise Immunity
- Lead (Pb)-free

## APPLICATIONS

- Zero Voltage Switching SMPS
- Telecom and Server Power Supplies
- Uninterruptible Power Supplies
- Motor Control Applications

## ORDERING INFORMATION

Package	TO-220 FULLPAK
Lead (Pb)-free	IRFIB5N50LPbF SiHFIB5N50L-E3

## ABSOLUTE MAXIMUM RATINGS $T_C = 25$ °C, unless otherwise noted

PARAMETER	SYMBOL	LIMIT	UNIT
Drain-Source Voltage	$V_{DS}$	500	V
Gate-Source Voltage	$V_{GS}$	$\pm 30$	
Continuous Drain Current	$I_D$	4.7	A
		3.0	
Pulsed Drain Current <sup>a</sup>	$I_{DM}$	16	
Linear Derating Factor		0.33	W/°C
Single Pulse Avalanche Energy <sup>b</sup>	$E_{AS}$	140	mJ
Avalanche Current <sup>a</sup>	$I_{AR}$	4.0	A
Repetitive Avalanche Energy <sup>a</sup>	$E_{AR}$	3.0	mJ
Maximum Power Dissipation	$P_D$	42	W
Peak Diode Recovery dV/dt <sup>c</sup>	dV/dt	13	V/ns
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	- 55 to + 150	°C
Soldering Recommendations (Peak Temperature)	for 10 s	300 <sup>d</sup>	
Mounting Torque	6-32 or M3 screw	10	lbf · in
		1.1	N · m

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Starting  $T_J = 25$  °C,  $L = 18$  mH,  $R_G = 25$  Ω,  $I_{AS} = 4.0$  A, dV/dt = 13 V/ns, (see fig. 12).

c.  $I_{SD} \leq 4.0$  A,  $dI/dt \leq 280$  A/μs,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 150$  °C.

d. 1.6 mm from case.

**THERMAL RESISTANCE RATINGS**

PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	65	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.0	

**SPECIFICATIONS** T<sub>J</sub> = 25 °C, unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
<b>Static</b>							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.43	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA		3.0	-	5.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 30 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	50	μA
		V <sub>DS</sub> = 400 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C		-	-	2.0	mA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.4 A <sup>b</sup>	-	0.67	0.80	Ω
Forward Transconductance	g <sub>f</sub>	V <sub>DS</sub> = 50 V, I <sub>D</sub> = 2.4 A		2.8	-	-	S
<b>Dynamic</b>							
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5		-	1000	-	pF
Output Capacitance	C <sub>oss</sub>			-	110	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	12	-	
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 1.0 V, f = 1.0 MHz	-	1360	-	
Effective Output Capacitance	C <sub>oss eff.</sub>		V <sub>DS</sub> = 400 V, f = 1.0 MHz	-	31	-	
Effective Output Capacitance (Energy Related)	C <sub>oss eff.</sub> (ER)		V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>	-	75	-	
Total Gate Charge	Q <sub>g</sub>			-	55	-	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 4.0 A, V <sub>DS</sub> = 400 V, see fig. 7 and 16 <sup>b</sup>	-	-	45	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	-	13	
Internal Gate Resistance	R <sub>G</sub>			-	-	23	
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 4.0 A, R <sub>G</sub> = 9.0 Ω, V <sub>GS</sub> = 10 V, see fig. 11a and 11b <sup>b</sup>		-	13	-	ns
Rise Time	t <sub>r</sub>			-	17	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	26	-	
Fall Time	t <sub>f</sub>			-	10	-	
<b>Drain-Source Body Diode Characteristics</b>							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.7	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	16	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 4.0 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 4.0 A, T <sub>J</sub> = 125 °C, dI/dt = 100 A/μs <sup>b</sup>		-	73	110	ns
				-	99	150	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 4.0 A, T <sub>J</sub> = 125 °C, dI/dt = 100 A/μs <sup>b</sup>		-	200	310	nC
				-	360	540	

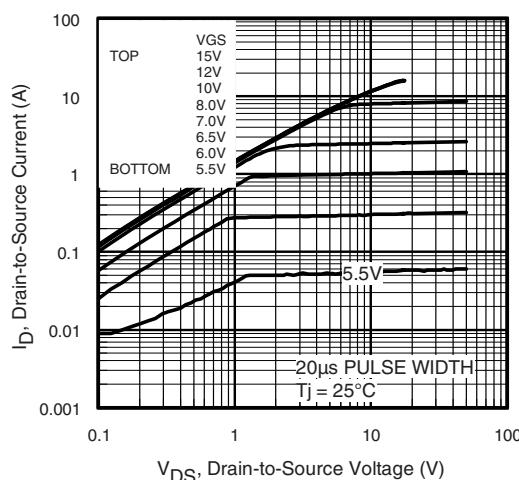
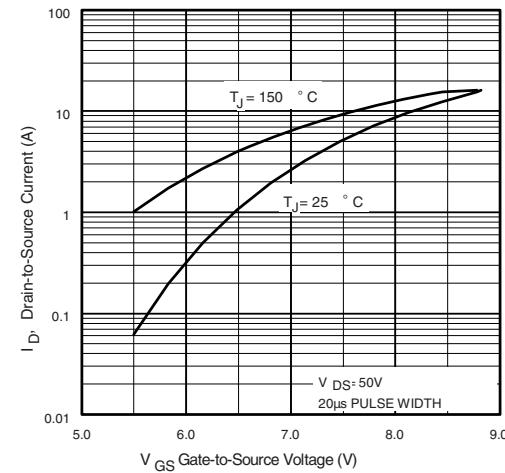
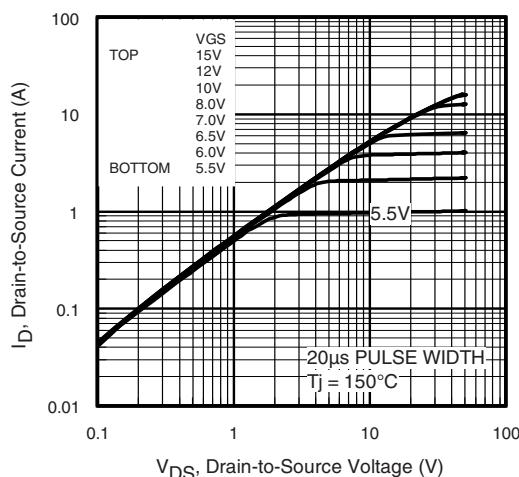
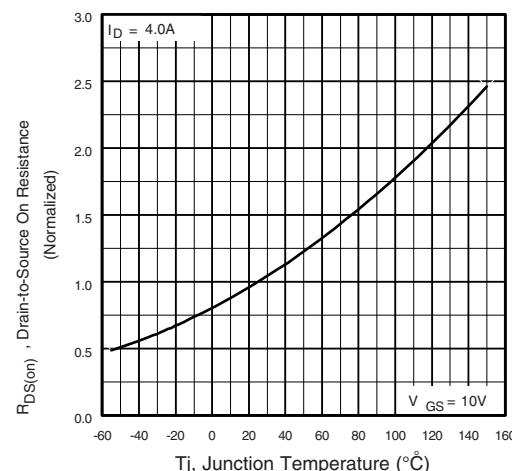
**SPECIFICATIONS**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Drain-Source Body Diode Characteristics</b>						
Body Diode Reverse Recovery Current	$I_{RRM}$	$T_J = 25^\circ\text{C}$	-	6.7	10	A
Forward Turn-On Time	$t_{on}$	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )				

**Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300 \mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .  
 $C_{oss}$  eff. (ER) is a fixed capacitance that stores the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80 %  $V_{DS}$ .

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**TYPICAL CHARACTERISTICS**  $25^\circ\text{C}$ , unless otherwise noted

**Fig. 1 - Typical Output Characteristics**

**Fig. 3 - Typical Transfer Characteristics**

**Fig. 2 - Typical Output Characteristics**

**Fig. 4 - Normalized On-Resistance vs. Temperature**

# IRFIB5N50L, SiHFIB5N50L

Vishay Siliconix

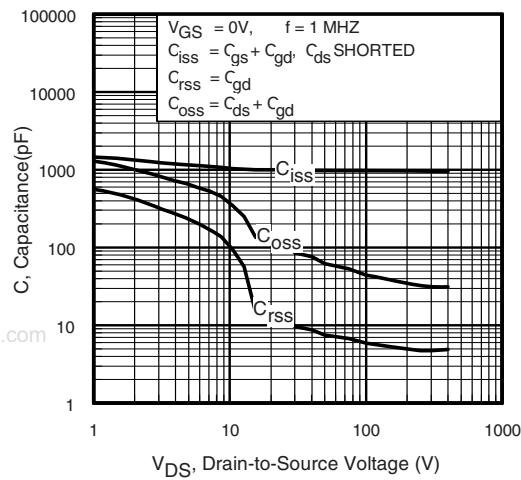


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

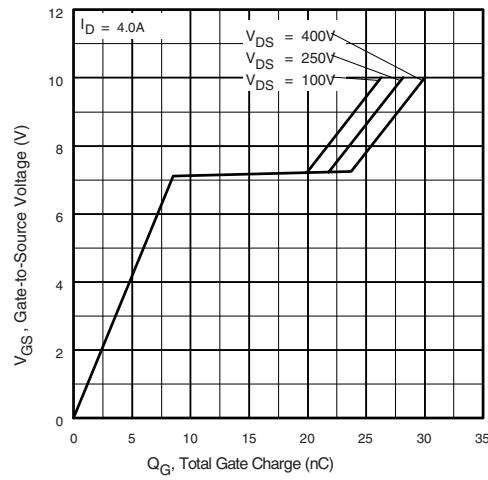


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

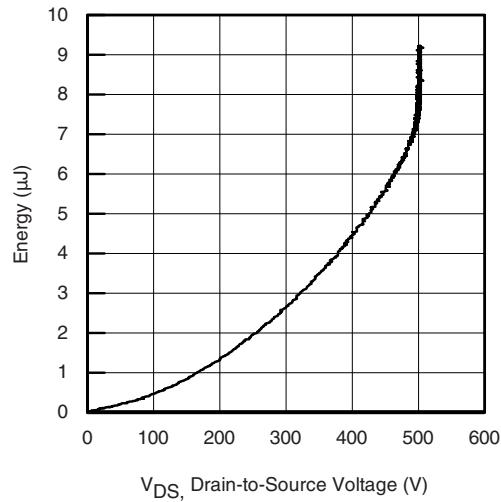


Fig. 6 - Typical Output Capacitance Stored Energy vs.  $V_{DS}$

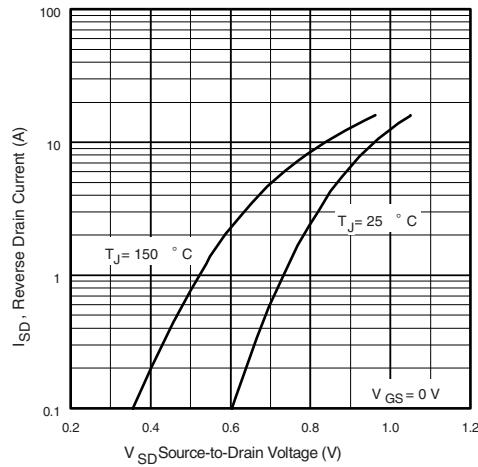
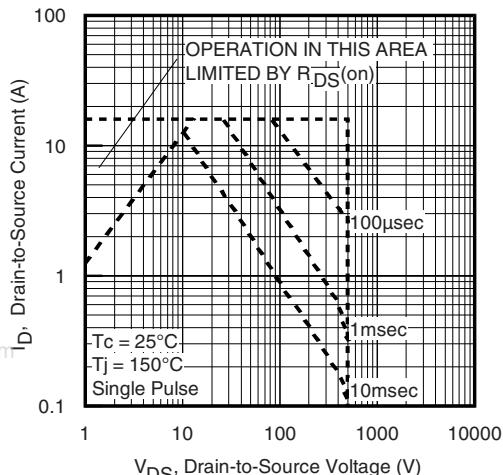
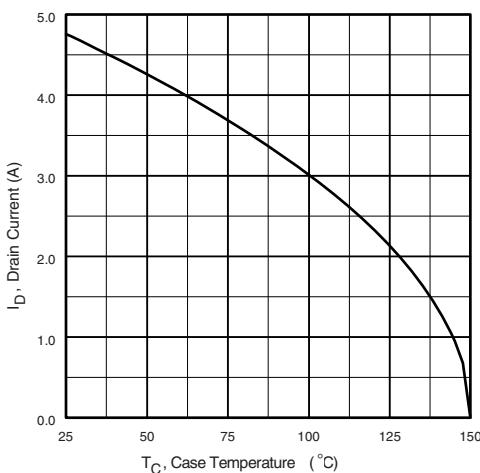
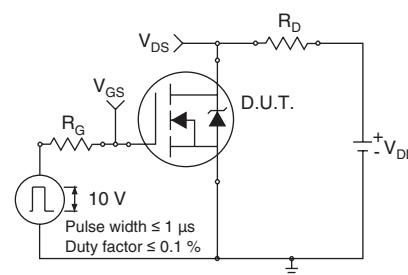
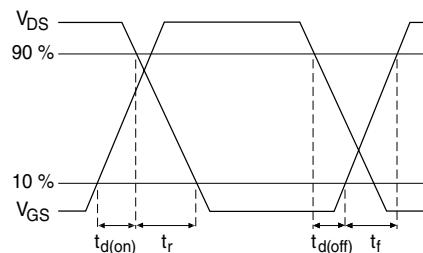
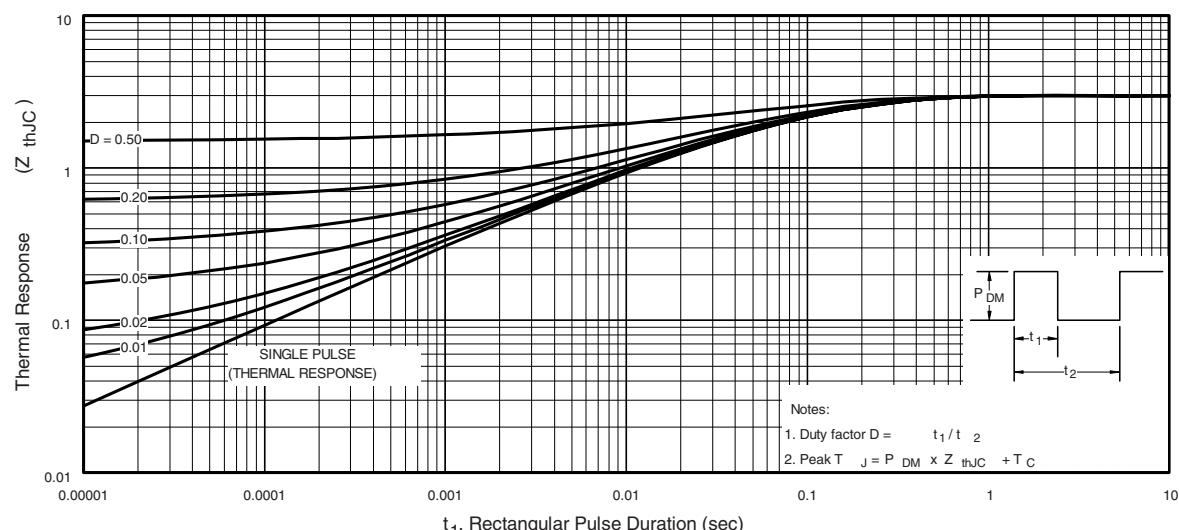


Fig. 8 - Typical Source-Drain Diode Forward Voltage


**Fig. 9 - Maximum Safe Operating Area**

**Fig. 10 - Maximum Drain Current vs. Case Temperature**

**Fig. 11a - Switching Time Test Circuit**

**Fig. 11b - Switching Time Waveforms**

**Fig. 12 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**

# IRFIB5N50L, SiHFIB5N50L



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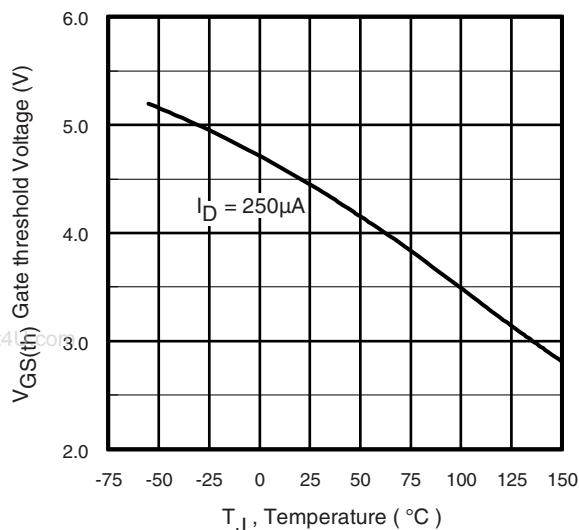


Fig. 13 - Threshold Voltage vs. Temperature

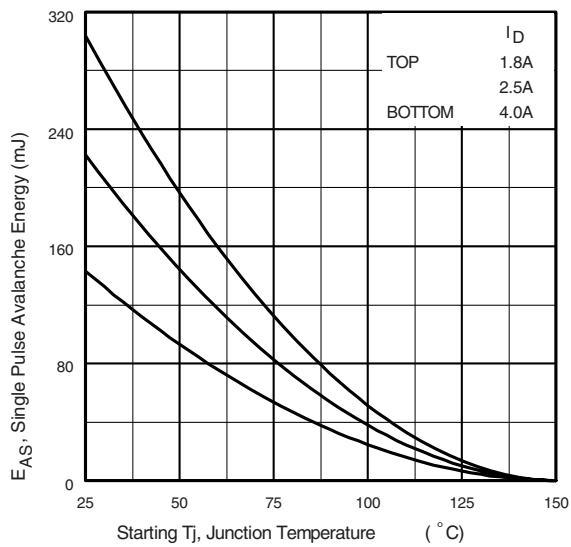


Fig. 14 - Maximum Avalanche Energy vs. Drain Current

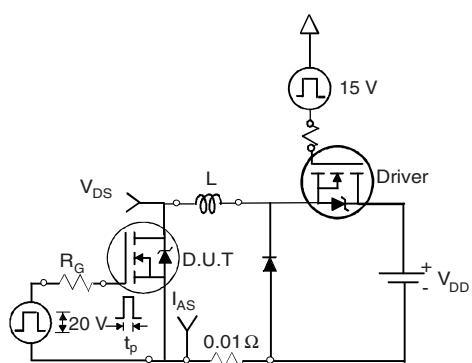


Fig. 15a - Unclamped Inductive Test Circuit

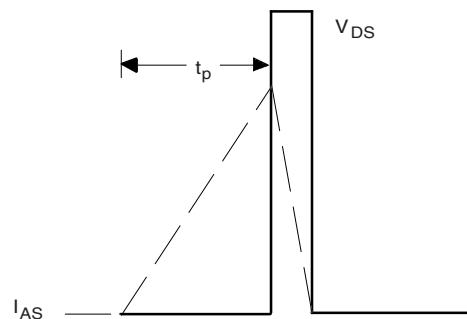


Fig. 15b - Unclamped Inductive Waveforms

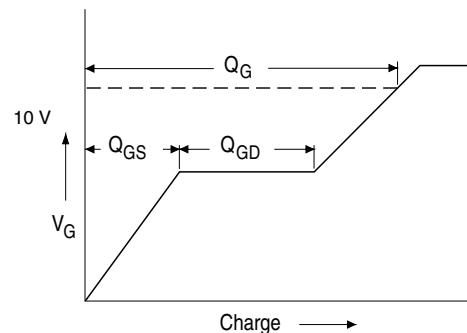


Fig. 16a - Basic Gate Charge Waveform

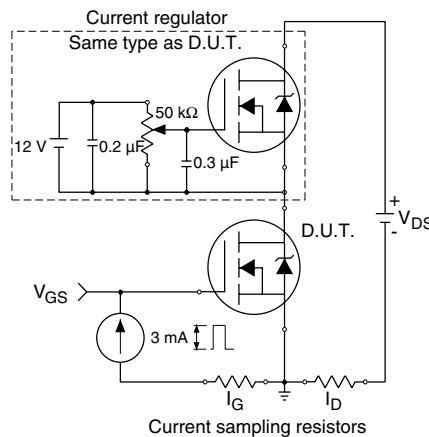
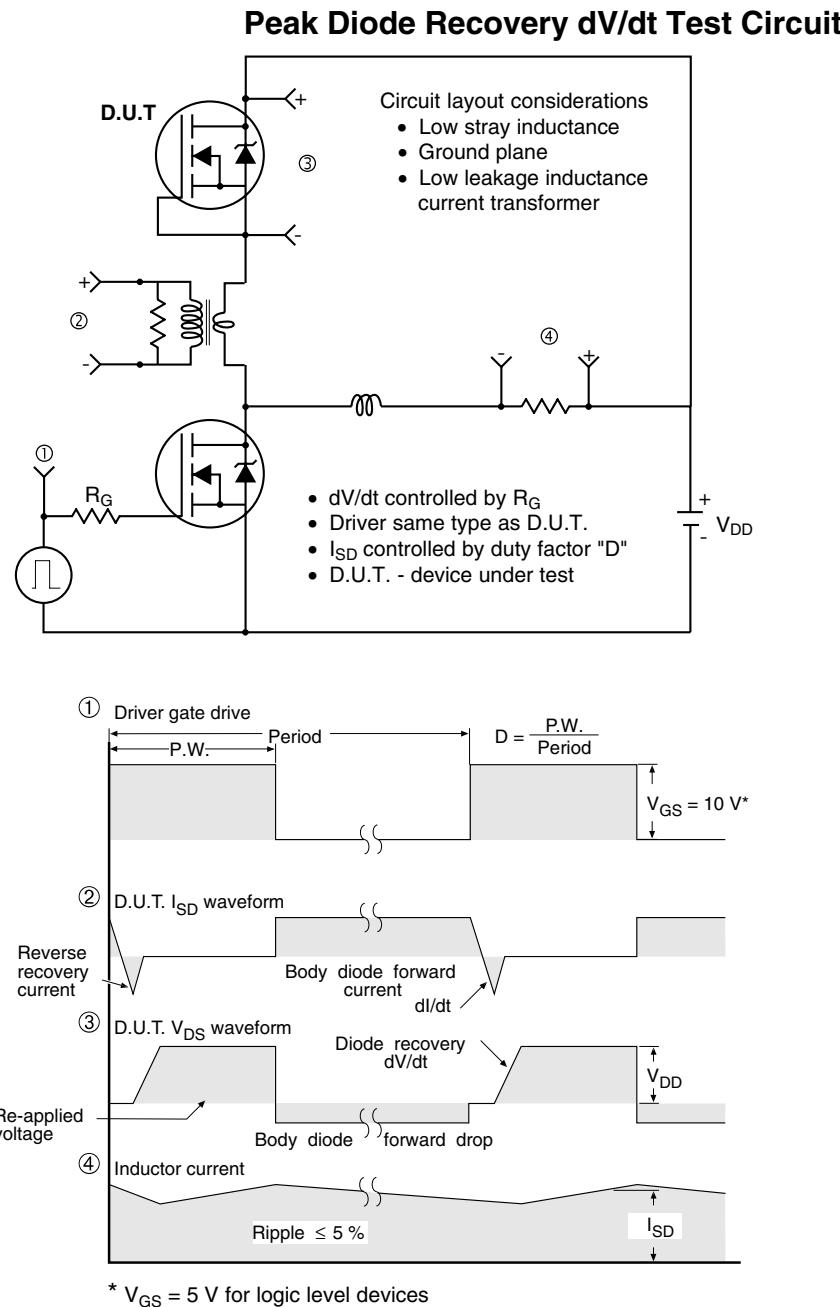


Fig. 16b - Gate Charge Test Circuit


**Fig. 17 - For N-Channel**

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